

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/449,001	SENN ET AL.	
Examiner Pablo N. Tran	2618	

	SEARCHED					
Class	Subclass	Date	Examiner			
455	432	05/14/81				
	432 406 433 405-411 445		V			
	433					
	405-411					
	445					
	,					
		····				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
taet / west	ه چارها به	, ,2		
····				